Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/679,000	CHANG ET AL.
	Examiner	Art Unit
	Sheng-Jen Tsai	2186

SEARCHED

Class	Subclass	Date	Examiner
714	763	12/20/2005	SJT
711	103	12/20/2005	SJT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES
(INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East: "ECC" with "flash" "NAND flash memoy" "MLC NAND flash memory" "hamming code"	12/20/2005	SJT